

<b>Notice of References Cited</b>	Application/Control No. 10/757,829	Applicant(s)/Patent Under Reexamination SHIRAISHI ET AL.	
	Examiner Tai Van Nguyen	Art Unit 3729	Page 1 of 1

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	C	US-5,625,149	04-1997	Gururaja et al.	73/632
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	M	US-			

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**NON-PATENT DOCUMENTS**

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